# PHB108NQ03LT

# N-channel TrenchMOS logic level FET

Rev. 04 — 2 February 2009

**Product data sheet** 

## 1. Product profile

#### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

#### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Simple gate drive required due to low gate charge
- Suitable for logic level gate drive sources

### 1.3 Applications

■ DC-to-DC convertors

Switched-mode power supplies

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	25	V
$I_D$	drain current	$T_{mb} = 25 ^{\circ}\text{C}; V_{GS} = 5 \text{V};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	75	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	187	W
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A};$ $V_{DS} = 12 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 12</u> ; see <u>Figure 13</u>	-	5.6	-	nC
Static ch	aracteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 10}{\text{Figure } 11};$	-	5.3	6	mΩ



## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description		Simplified outline	Graphic symbol
1	G	gate			
2	D	drain	[1]	mb	D
3	S	source			$G \longrightarrow \overline{A}$
mb	D	mounting base; connected to drain		1 3	mbb076 S
				SOT404 (D2PAK)	

[1] It is not possible to make a connection to pin 2

## 3. Ordering information

Table 3. Ordering information

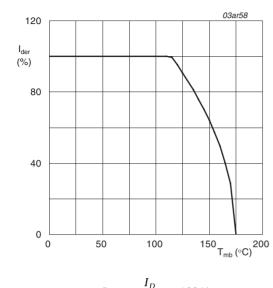
Type number	Package					
	Name	Description	Version			
PHB108NQ03LT	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404			

## 4. Limiting values

#### Table 4. Limiting values

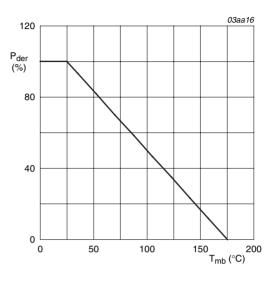
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 ^{\circ}\text{C}; T_j \le 175 ^{\circ}\text{C}$	-	25	V
$V_{DGR}$	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	25	V
$V_{GS}$	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	75	Α
		V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	-	75	А
I <sub>DM</sub>	peak drain current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$ ; see Figure 3	-	240	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	187	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-dr	ain diode				
Is	source current	T <sub>mb</sub> = 25 °C	-	75	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	240	Α
Avalance	uggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 43 A; $V_{sup}$ ≤ 25 V; unclamped; $t_p$ = 0.25 ms; $R_{GS}$ = 50 $\Omega$	-	180	mJ



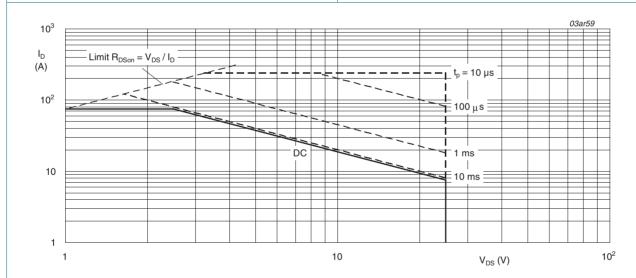
 $I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$ 

Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25$ °C;  $I_{DM}$  is single pulse;  $V_{GS} = 5V$ 

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air; mounted on a printed-circuit board; minimum footprint	-	50	-	K/W
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see Figure 4	-	-	0.8	K/W

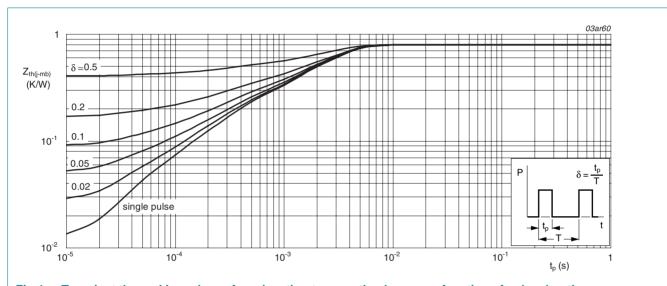


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
_	aracteristics			- •		
V <sub>(BR)DSS</sub>	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	22	-	-	V
-	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	25	-	-	V
V <sub>GS(th)</sub> gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see <u>Figure 8</u> ; see <u>Figure 9</u>	0.5	-	-	V	
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 8</u> ; see <u>Figure 9</u>	-	-	2.2	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 8</u> ; see <u>Figure 9</u>	1	1.5	2	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 ^{\circ}\text{C}$	-	-	500	μΑ
		$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
$I_{GSS}$	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	100	nΑ
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	100	nA
R <sub>DSon</sub> drain-source on-state resistance		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 175 °C;$ see <u>Figure 10</u> ; see <u>Figure 11</u>	-	12.1	13.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	-	5.3	6	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	-	6.7	7.5	mΩ
$R_G$	internal gate resistance (AC)	f = 1 MHz; T <sub>j</sub> = 25 °C	-	1.2	-	Ω
Dynamic	characteristics					
Q <sub>G(tot)</sub> total g	total gate charge	$I_D$ = 25 A; $V_{DS}$ = 12 V; $V_{GS}$ = 4.5 V; $T_j$ = 25 °C; see <u>Figure 12</u> ; see <u>Figure 13</u>	-	16.3	-	nC
		$I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 4.5 \text{ V};$ $T_j = 25 \text{ °C}$	-	12.5	-	nC
Q <sub>GS</sub>	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 12 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	4	-	nC
Q <sub>GS1</sub>	pre-threshold gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 12;</u> see <u>Figure 13</u>	-	2.5	-	nC
Q <sub>GS2</sub>	post-threshold gate-source charge		-	1.5	-	nC
$Q_{GD}$	gate-drain charge		-	5.6	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 25 \text{ A}$ ; $V_{DS} = 12 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 12; see Figure 13	-	2.4	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 12 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 14}{\text{ V}}$	-	1375	-	pF
		$V_{DS} = 0 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}$	-	2120	-	pF
C <sub>oss</sub>	output capacitance	$V_{DS} = 12 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	640	-	pF
C <sub>rss</sub>	reverse transfer capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	250	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 12 V; $R_L$ = 0.5 $\Omega$ ; $V_{GS}$ = 4.5 V;	-	15	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5.6 \Omega; T_j = 25  ^{\circ}C$	-	38	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	32	-	ns
t <sub>f</sub>	fall time		-	25	-	ns
Source-di	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 15</u>	-	0.86	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;	-	34	-	ns
Qr	recovered charge	V <sub>DS</sub> = 25 V; T <sub>j</sub> = 25 °C	-	21	-	nC

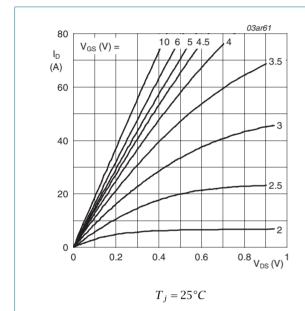
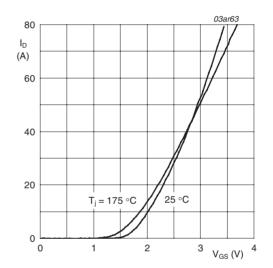


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25$ °C and 175°C;  $V_{DS} > I_D \times R_{DSon}$ 

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

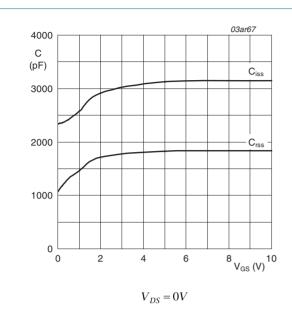
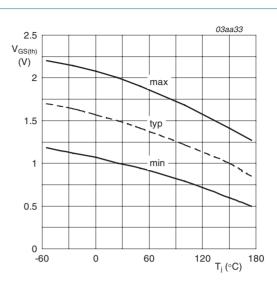
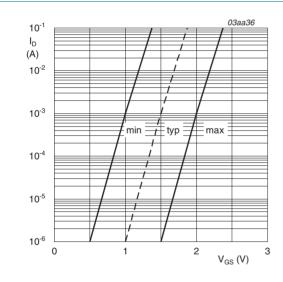


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values



 $I_D = 1 \, mA; V_{DS} = V_{GS}$ 

Fig 8. Gate-source threshold voltage as a function of junction temperature



 $T_{j}=25\,^{\circ}C; V_{DS}=V_{GS}$  Fig 9. Sub-threshold drain current as a function of

gate-source voltage

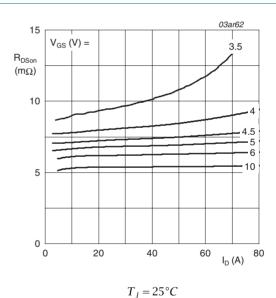


Fig 10. Drain-source on-state resistance as a function of drain current; typical values

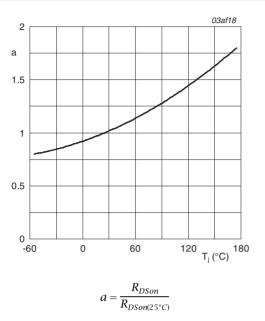
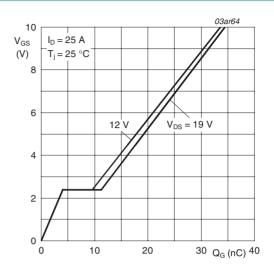


Fig 11. Normalized drain-source on-state resistance factor as a function of junction temperature



$$I_D = 25A; V_{DS} = 12V \text{ and } 19V$$

Fig 12. Gate-source voltage as a function of gate charge; typical values

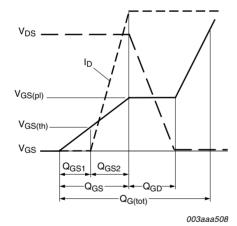
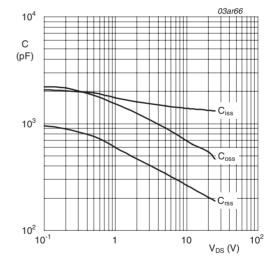


Fig 13. Gate charge waveform definitions



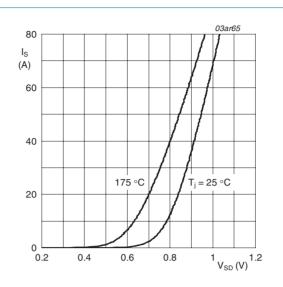
$$V_{GS} = 0V; f = 1MHz$$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 $T_j = 25^{\circ} C \text{ and } 175^{\circ} C; V_{GS} = 0V$ 

Fig 15. Source current as a function of source-drain voltage; typical values

## 7. Package outline

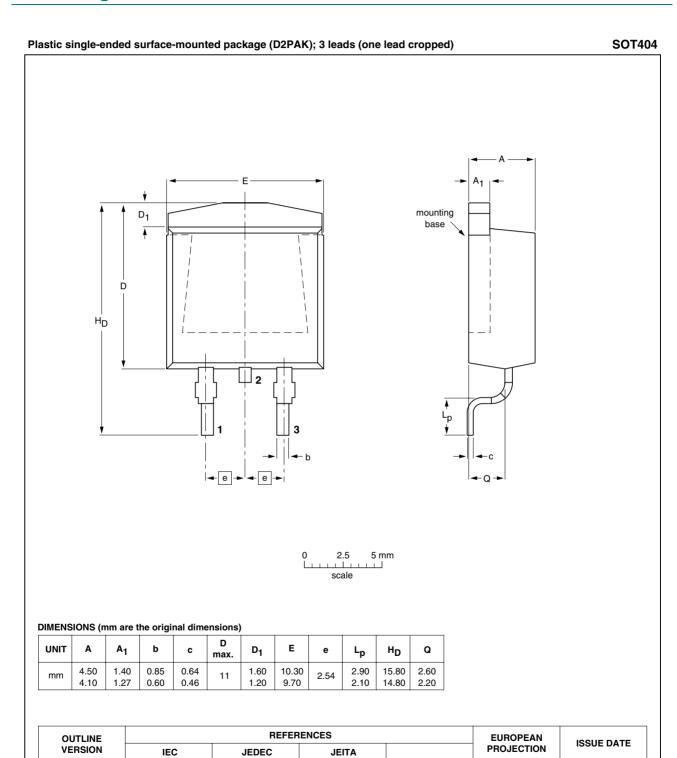


Fig 16. Package outline SOT404 (D2PAK)

SOT404

05-02-11

06-03-16

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## N-channel TrenchMOS logic level FET

## **Revision history**

#### Table 7. **Revision history**

**Product data sheet** 

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHB108NQ03LT_4	20090202	Product data sheet	-	PHB_PHD_PHU108NQ03LT_3
Modifications:		t of this data sheet ha of NXP Semiconduct	•	d to comply with the new identity
	<ul> <li>Legal texts</li> </ul>	s have been adapted	to the new compa	ny name where appropriate.
PHB_PHD_PHU108NQ03LT_3 (9397 750 14707)	20050418	Product data sheet	2004070095	PHP_PHB_PHD108NQ03LT-02
PHP_PHB_PHD108NQ03LT-02 (9397 750 10159)	20020911	Product data	-	PHP_PHB_PHD108NQ03LT-01
PHP_PHB_PHD108NQ03LT-01 (9397 750 09065)	20011218	Product data	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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# PHB108NQ03LT

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